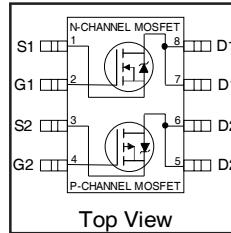


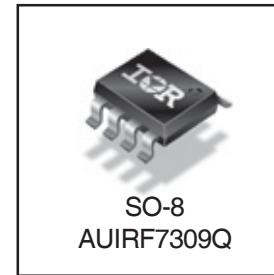
Features

- Advanced Planar Technology
- Low On-Resistance
- Logic Level Gate Drive
- Dual N and P Channel MOSFET
- Dynamic dV/dT Rating
- 150°C Operating Temperature
- Fast Switching
- Lead-Free, RoHS Compliant
- Automotive Qualified*



HEXFET® Power MOSFET

	N-CH	P-CH
V_{(BR)DSS}	30V	-30V
R_{DS(on)} max.	0.05Ω	0.10Ω
I_D	4.7A	-3.5A



Description

Specifically designed for Automotive applications, this cellular design of HEXFET® Power MOSFETs utilizes the latest processing techniques to achieve low on-resistance per silicon area. This benefit combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in Automotive and a wide variety of other applications.

Base Part Number	Package Type	Standard Pack		Orderable Part Number
		Form	Quantity	
AUIRF7309Q	SO-8	Tube	95	AUIRF7309Q
		Tape and Reel	4000	AUIRF7309QTR

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (T_A) is 25°C, unless otherwise specified.

	Parameter	Max.		Units
		N-Channel	P-Channel	
I _D @ $T_A = 25^\circ\text{C}$	10 Sec. Pulsed Drain Current, $V_{GS} @ 10\text{V}$	4.7	-3.5	A
I _D @ $T_A = 25^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	4	-3.0	
I _D @ $T_A = 70^\circ\text{C}$	Continuous Drain Current, $V_{GS} @ 10\text{V}$	3.2	-2.4	
I _{DM}	Pulsed Drain Current ①	16	-12	
P _D @ $T_A = 25^\circ\text{C}$	Power Dissipation ④	1.4		W
	Linear Derating Factor ④	0.011		W/°C
V _{GS}	Gate-to-Source Voltage	± 20		V
dv/dt	Peak Diode Recovery dv/dt ②	6.9	-6.0	V/ns
T _J	Operating Junction and	-55 to + 150		°C
T _{STG}	Storage Temperature Range			

Thermal Resistance

	Parameter	Typ.	Max.	Units
R _{θJA}	Junction-to-Ambient (PCB Mount, steady state) ④	—	90	°C/W

HEXFET® is a registered trademark of International Rectifier.

*Qualification standards can be found at <http://www.irf.com/>

Static Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Parameter		Min.	Typ.	Max.	Units	Conditions
$V_{(\text{BR})\text{DSS}}$	Drain-to-Source Breakdown Voltage	N-Ch	30	—	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
		P-Ch	-30	—		$V_{GS} = 0\text{V}, I_D = -250\mu\text{A}$
$\Delta V_{(\text{BR})\text{DSS}/\Delta T_J}$	Breakdown Voltage Temp. Coefficient	N-Ch	—	0.032	$\text{V}/^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1\text{mA}$
		P-Ch	—	-0.037		Reference to $25^\circ\text{C}, I_D = -1\text{mA}$
$R_{DS(\text{on})}$	Static Drain-to-Source On-Resistance	N-Ch	—	—	Ω	$V_{GS} = 10\text{V}, I_D = 2.4\text{A}$ ③
		—	—	0.050		$V_{GS} = 4.5\text{V}, I_D = 2.0\text{A}$ ③
		P-Ch	—	—	Ω	$V_{GS} = -10\text{V}, I_D = 1.8\text{A}$ ③
		—	—	0.10		$V_{GS} = -4.5\text{V}, I_D = 1.5\text{A}$ ③
$V_{GS(\text{th})}$	Gate Threshold Voltage	N-Ch	1.0	—	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
		P-Ch	-1.0	—		$V_{DS} = V_{GS}, I_D = -250\mu\text{A}$
g_{fs}	Forward Transconductance	N-Ch	5.2	—	S	$V_{DS} = 15\text{V}, I_D = 2.4\text{A}$
		P-Ch	2.5	—		$V_{DS} = -24\text{V}, I_D = -1.8\text{A}$
I_{DSS}	Drain-to-Source Leakage Current	N-Ch	—	—	μA	$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}$
		P-Ch	—	—		$V_{DS} = -24\text{V}, V_{GS} = 0\text{V}$
		N-Ch	—	—		$V_{DS} = 24\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$
		P-Ch	—	—		$V_{DS} = -24\text{V}, V_{GS} = 0\text{V}, T_J = 125^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	N-P	—	—	nA	$V_{GS} = 20\text{V}$
	Gate-to-Source Reverse Leakage	N-P	—	—		$V_{GS} = -20\text{V}$

Dynamic Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

Parameter		Min.	Typ.	Max.	Units	Conditions
Q_g	Total Gate Charge	N-Ch	—	25	nC	N-Channel $I_D = 2.6\text{A}, V_{DS} = 16\text{V}, V_{GS} = 4.5\text{V}$ ③
		P-Ch	—	25		P-Channel $I_D = -2.2\text{A}, V_{DS} = -16\text{V}, V_{GS} = -4.5\text{V}$
Q_{gs}	Gate-to-Source Charge	N-Ch	—	2.9	ns	N-Channel $V_{DD} = 10\text{V}, I_D = 2.6\text{A} R_G = 6.0\Omega$ $R_D = 3.8\Omega$
		P-Ch	—	2.9		
Q_{gd}	Gate-to-Drain ("Miller") Charge	N-Ch	—	7.9	ns	P-Channel $V_{DD} = -10\text{V}, I_D = -2.2\text{A} R_G = 6.0\Omega$ $R_D = 4.5\Omega$
		N-Ch	—	9.0		
$t_{d(on)}$	Turn-On Delay Time	P-Ch	—	6.8	ns	Between lead, 6mm (0.25in.) from package and center of die contact
		N-Ch	—	11		
t_r	Rise Time	P-Ch	—	21	ns	P-Channel $V_{DD} = -10\text{V}, I_D = -2.2\text{A} R_G = 6.0\Omega$ $R_D = 4.5\Omega$
		N-Ch	—	17		
$t_{d(off)}$	Turn-Off Delay Time	N-Ch	—	22	ns	N-Channel $V_{DD} = 10\text{V}, I_D = 2.6\text{A} R_G = 6.0\Omega$ $R_D = 3.8\Omega$
		P-Ch	—	25		
t_f	Fall Time	N-Ch	—	7.7	ns	N-Channel $V_{DD} = 10\text{V}, I_D = 2.6\text{A} R_G = 6.0\Omega$ $R_D = 3.8\Omega$
		P-Ch	—	18		
L_D	Internal Drain Inductance	N-P	—	4.0	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_s	Internal Source Inductance	N-P	—	6.0		
C_{iss}	Input Capacitance	N-Ch	—	520	pF	N-Channel $V_{GS} = 0\text{V}, V_{DS} = 15\text{V}, f = 1.0\text{MHz}$ ③
		P-Ch	—	440		
C_{oss}	Output Capacitance	N-Ch	—	180	pF	P-Channel $V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1.0\text{MHz}$ ③
		P-Ch	—	200		
C_{rss}	Reverse Transfer Capacitance	N-Ch	—	72	pF	P-Channel $V_{GS} = 0\text{V}, V_{DS} = -15\text{V}, f = 1.0\text{MHz}$ ③
		P-Ch	—	93		

Diode Characteristics

Parameter		Min.	Typ.	Max.	Units	Conditions
I_s	Continuous Source Current (Body Diode)	N-Ch	—	1.8	A	
		P-Ch	—	-1.8		
I_{SM}	Pulsed Source Current (Body Diode) ①	N-Ch	—	16	ns	N-Channel $T_J = 25^\circ\text{C}, I_S = 1.8\text{A}, V_{GS} = 0\text{V}$ ③ $T_J = 25^\circ\text{C}, I_S = -1.8\text{A}, V_{GS} = 0\text{V}$ ③
		P-Ch	—	-12		
V_{SD}	Diode Forward Voltage	N-Ch	—	1.0	V	N-Channel $T_J = 25^\circ\text{C}, I_F = 2.6\text{A}, di/dt = 100\text{A}/\mu\text{s}$ $P-Channel$ $T_J = 25^\circ\text{C}, I_F = -2.2\text{A}, di/dt = 100\text{A}/\mu\text{s}$
		P-Ch	—	-1.0		
t_{rr}	Reverse Recovery Time	N-Ch	—	47	ns	N-Channel $T_J = 25^\circ\text{C}, I_F = 2.6\text{A}, di/dt = 100\text{A}/\mu\text{s}$ $P-Channel$ $T_J = 25^\circ\text{C}, I_F = -2.2\text{A}, di/dt = 100\text{A}/\mu\text{s}$
		P-Ch	—	53		
Q_{rr}	Reverse Recovery Charge	N-Ch	—	84	nC	N-Channel $T_J = 25^\circ\text{C}, I_F = 2.6\text{A}, di/dt = 100\text{A}/\mu\text{s}$ $P-Channel$ $T_J = 25^\circ\text{C}, I_F = -2.2\text{A}, di/dt = 100\text{A}/\mu\text{s}$
		P-Ch	—	99		
t_{on}	Forward Turn-On Time	N-P	Intrinsic turn-on time is negligible (turn-on is dominated by LS+LD)			

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 23)
- ② N-Channel $I_{SD} \leq 2.4\text{A}$, $di/dt \leq 73\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 150^\circ\text{C}$.
P-Channel $I_{SD} \leq -1.8\text{A}$, $di/dt \leq 90\text{A}/\mu\text{s}$, $V_{DD} \leq V_{(\text{BR})\text{DSS}}$, $T_J \leq 150^\circ\text{C}$.
- ③ Pulse width $\leq 300\mu\text{s}$; duty cycle $\leq 2\%$.
- ④ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.

N-Channel

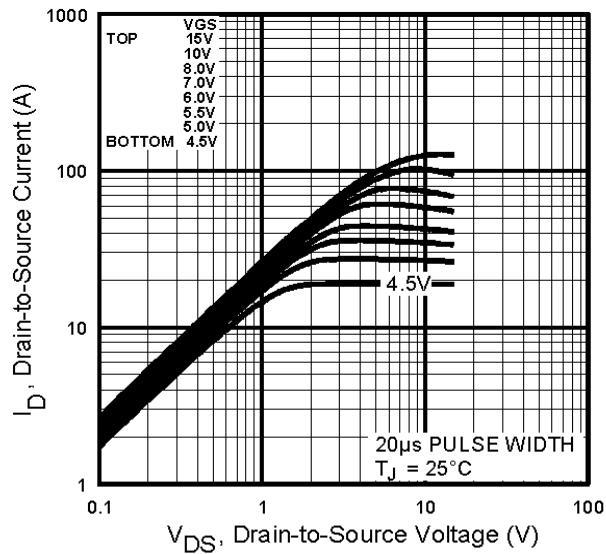


Fig 1. Typical Output Characteristics,
 $T_J = 25^\circ\text{C}$

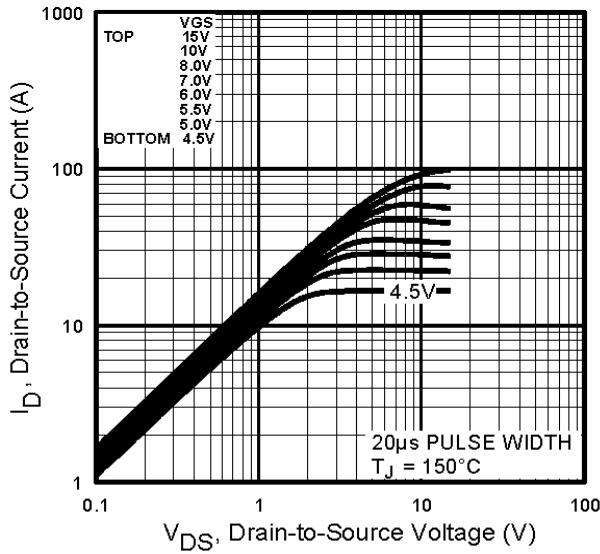


Fig 2. Typical Output Characteristics,
 $T_J = 150^\circ\text{C}$

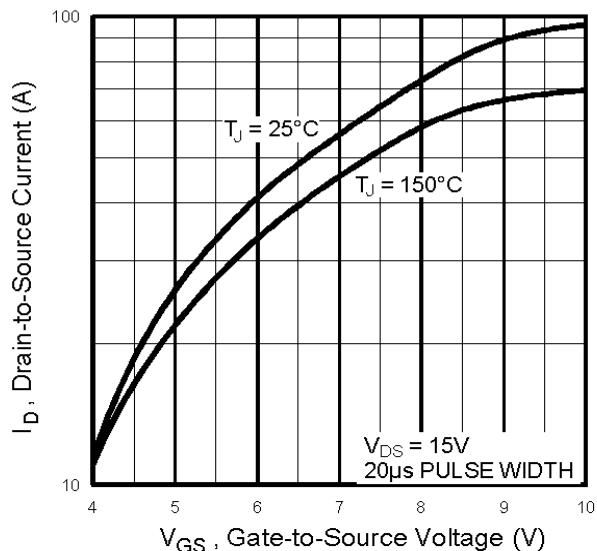


Fig 3. Typical Transfer Characteristics

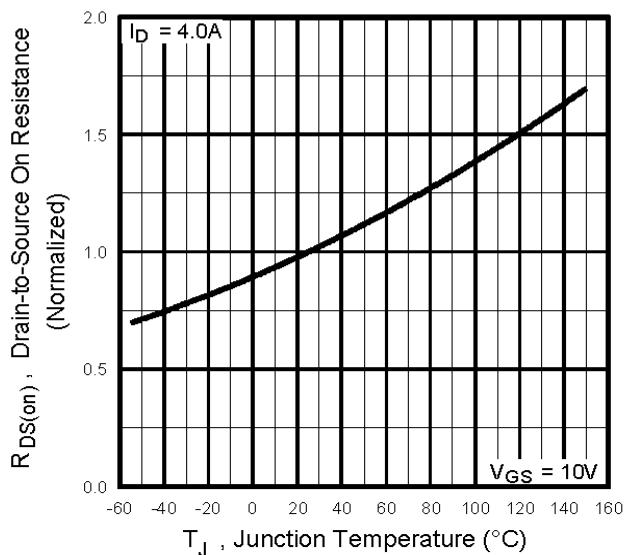


Fig 4. Normalized On-Resistance
Vs. Temperature

N-Channel

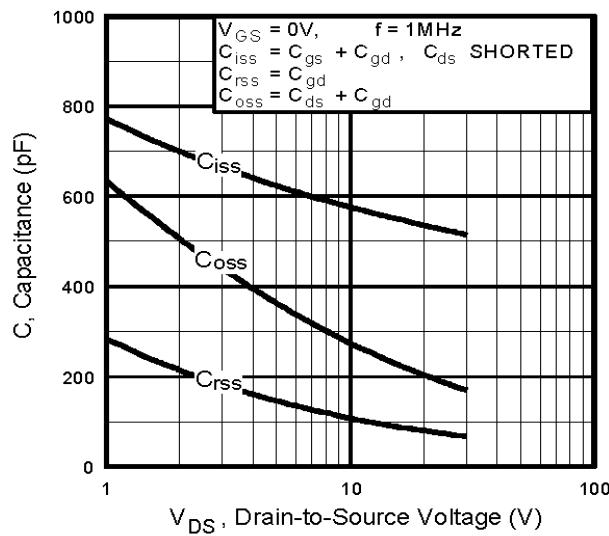


Fig 5. Typical Capacitance Vs. Drain-to-Source Voltage

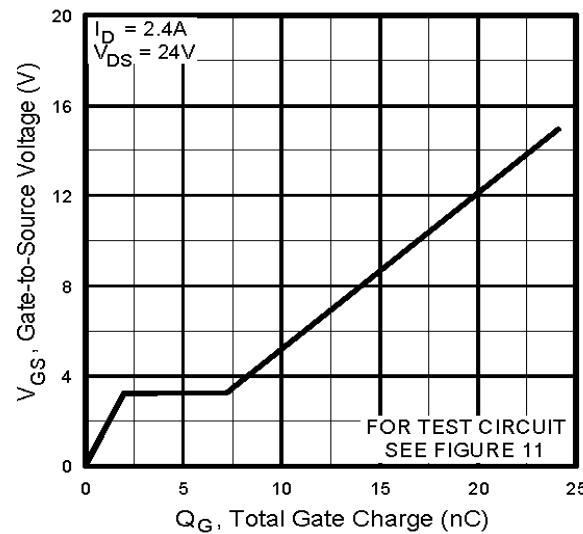


Fig 6. Typical Gate Charge Vs. Gate-to-Source Voltage

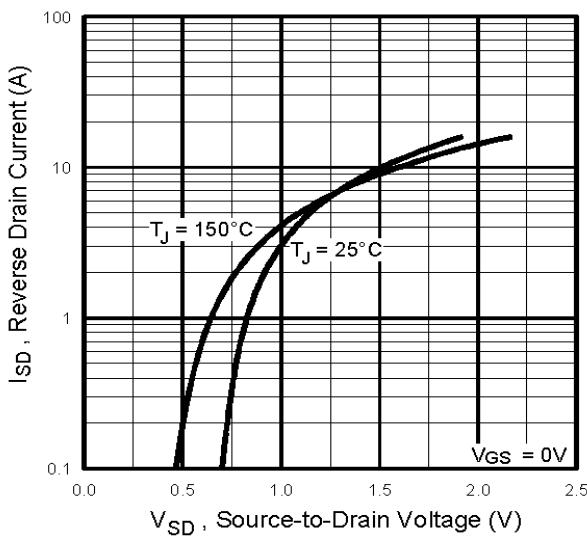


Fig 7. Typical Source-Drain Diode Forward Voltage

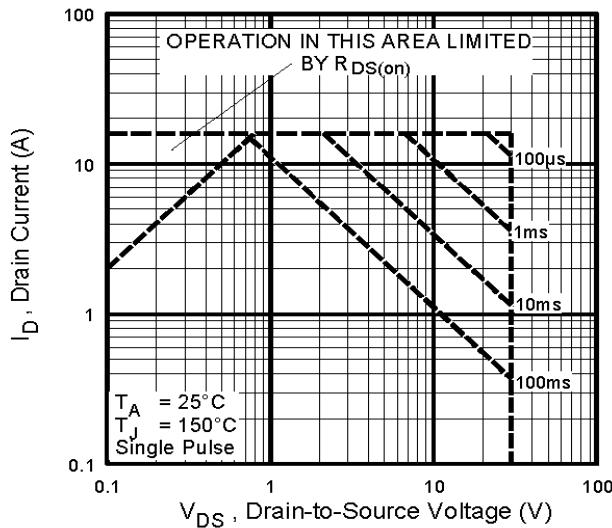


Fig 8. Maximum Safe Operating Area

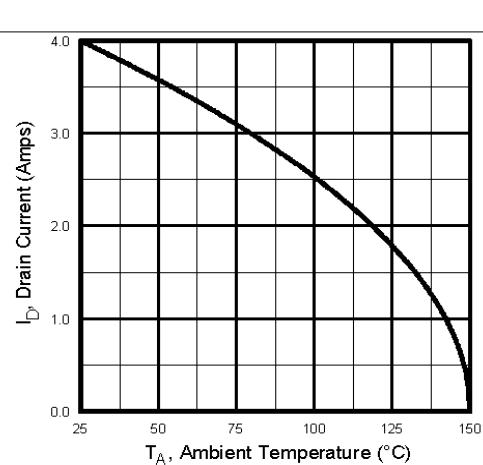


Fig 9. Max. Drain Current Vs. Ambient Temp.

N-Channel

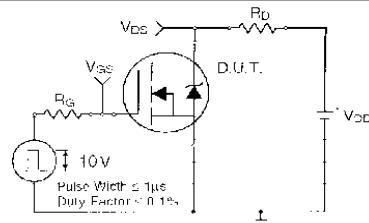


Fig 10a. Switching Time Test Circuit

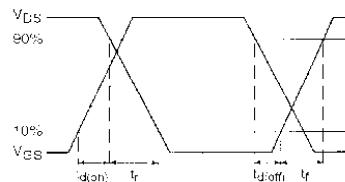


Fig 10b. Switching Time Waveforms

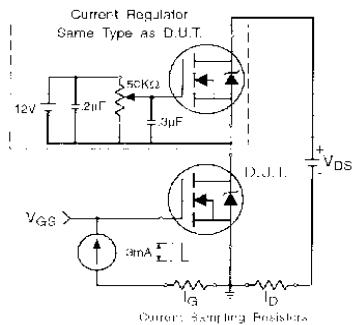


Fig 11a. Gate Charge Test Circuit

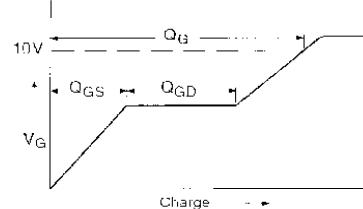


Fig 11b. Basic Gate Charge Waveform

P-Channel

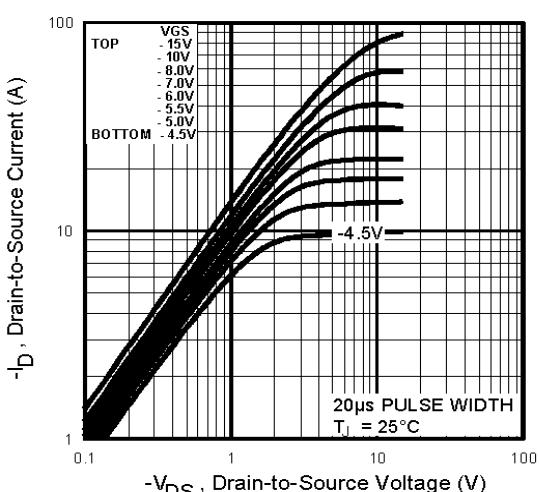


Fig 12. Typical Output Characteristics, $T_J = 25^\circ C$

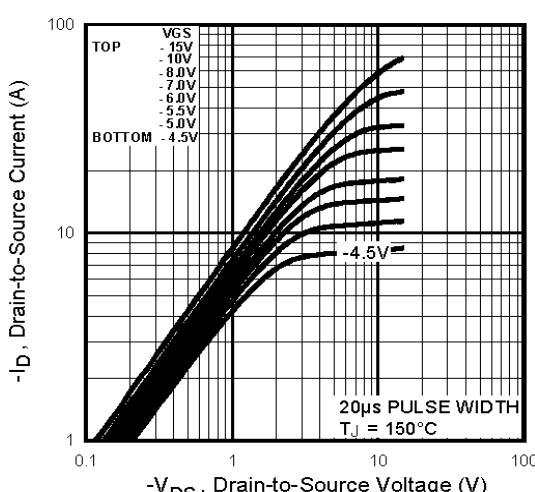
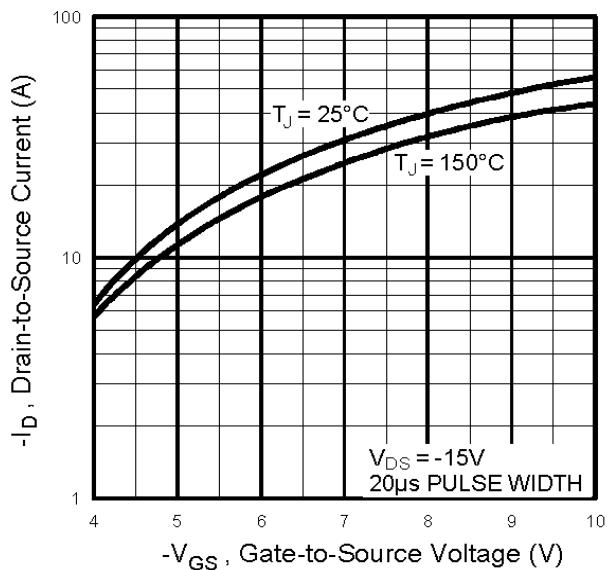
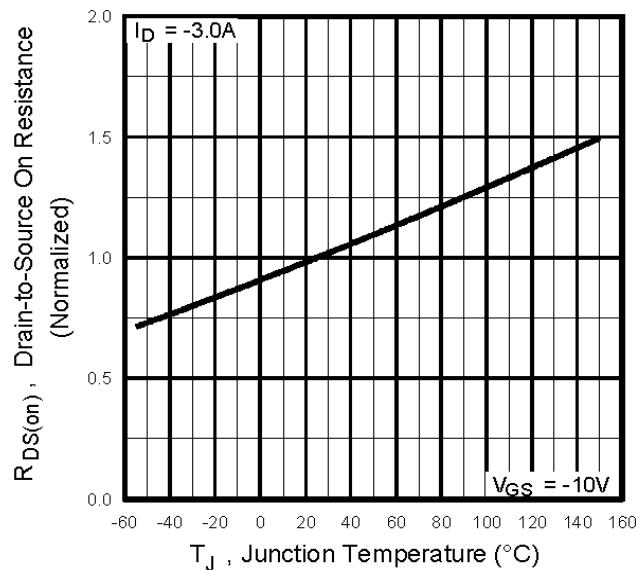
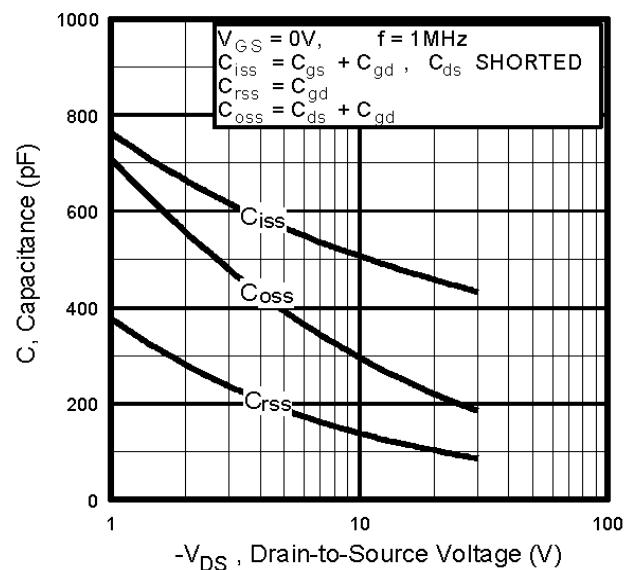
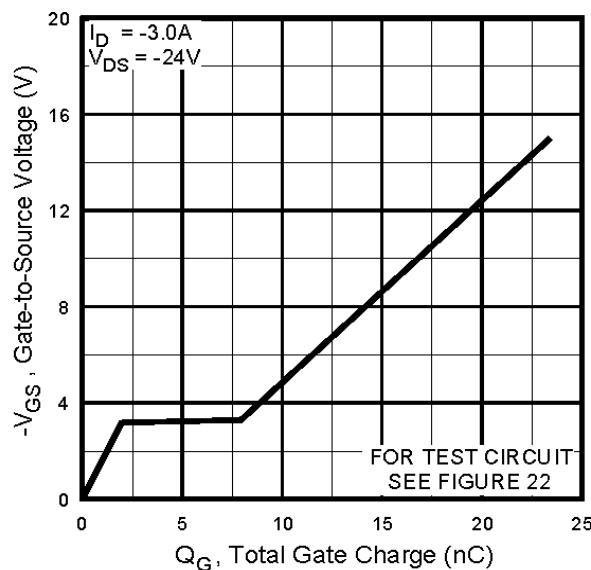


Fig 13. Typical Output Characteristics, $T_J = 150^\circ C$

P-Channel**Fig 14.** Typical Transfer Characteristics**Fig 15.** Normalized On-Resistance Vs. Temperature**Fig 16.** Typical Capacitance Vs. Drain-to-Source Voltage**Fig 17.** Typical Gate Charge Vs. Gate-to-Source Voltage

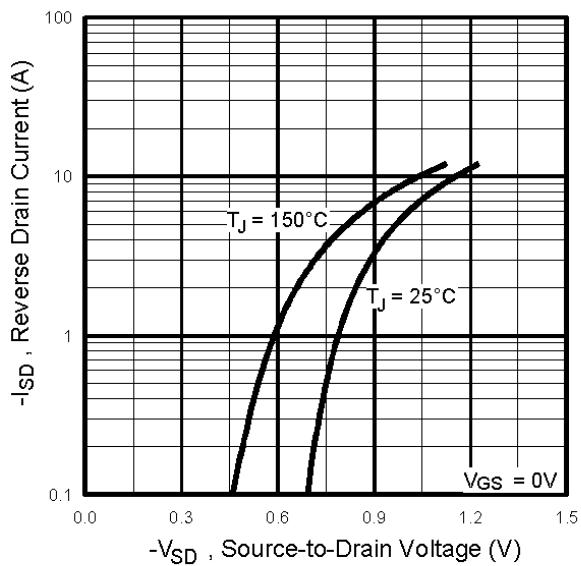
P-Channel

Fig 18. Typical Source-Drain Diode Forward Voltage

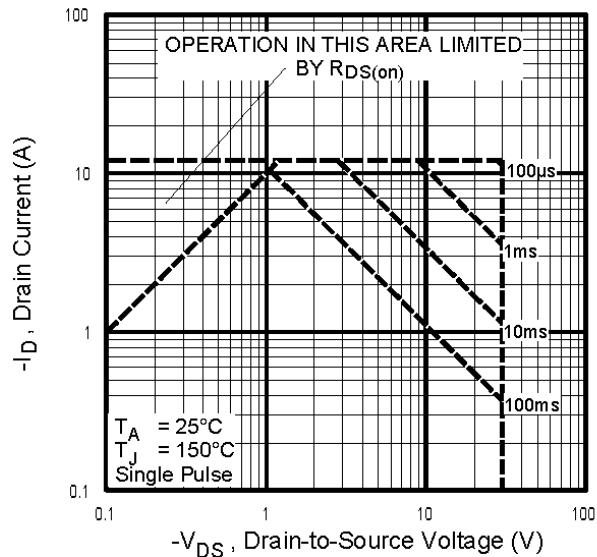


Fig 19. Maximum Safe Operating Area

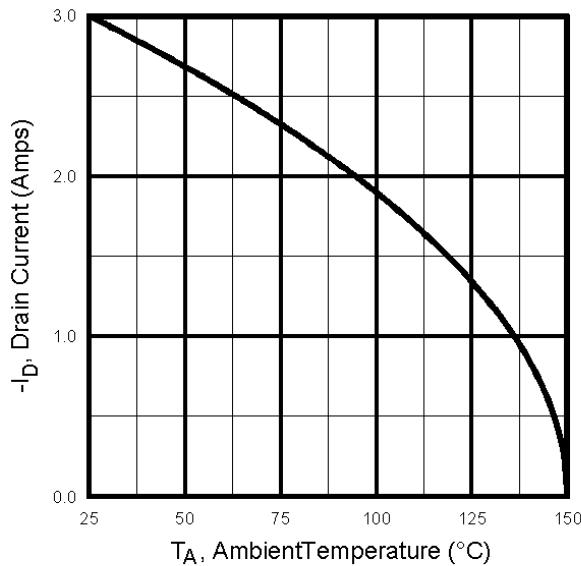


Fig 20. Max.Drain Current Vs. Ambient Temp.

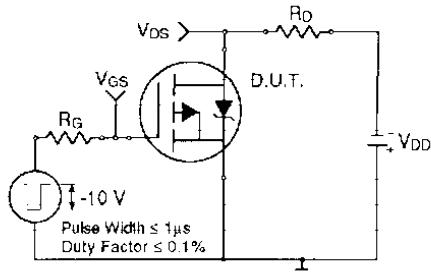


Fig 21a. Switching Time Test Circuit

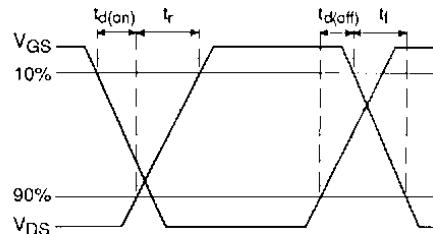
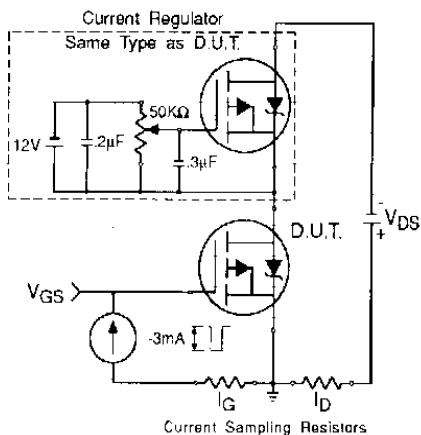
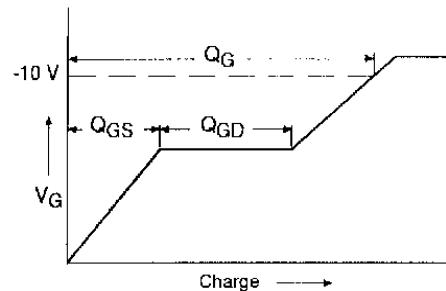
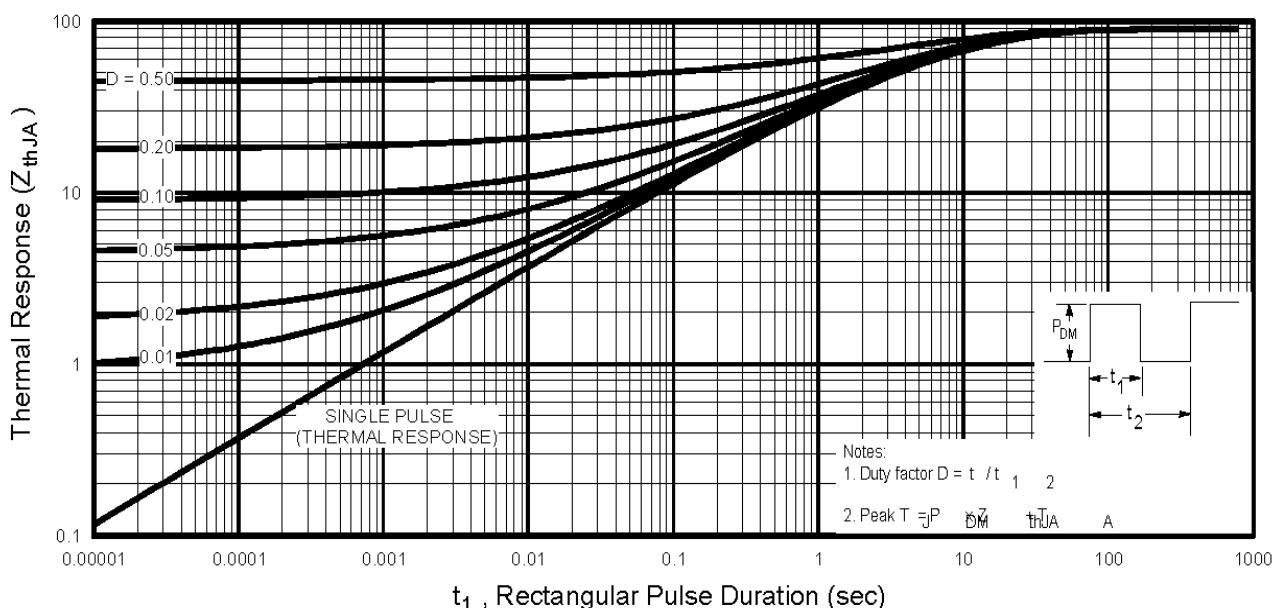
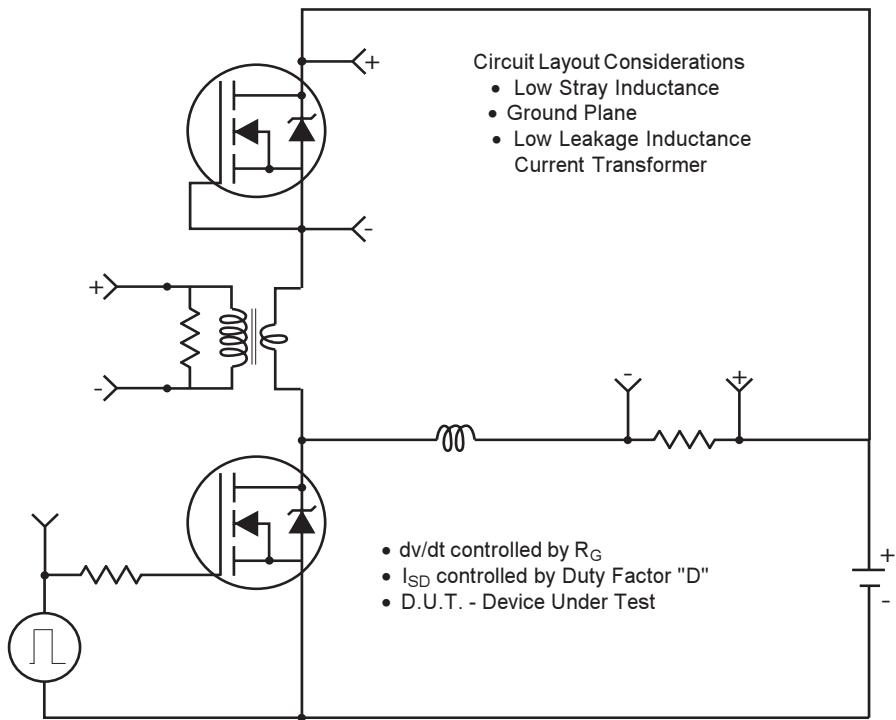


Fig 21b. Switching Time Waveforms

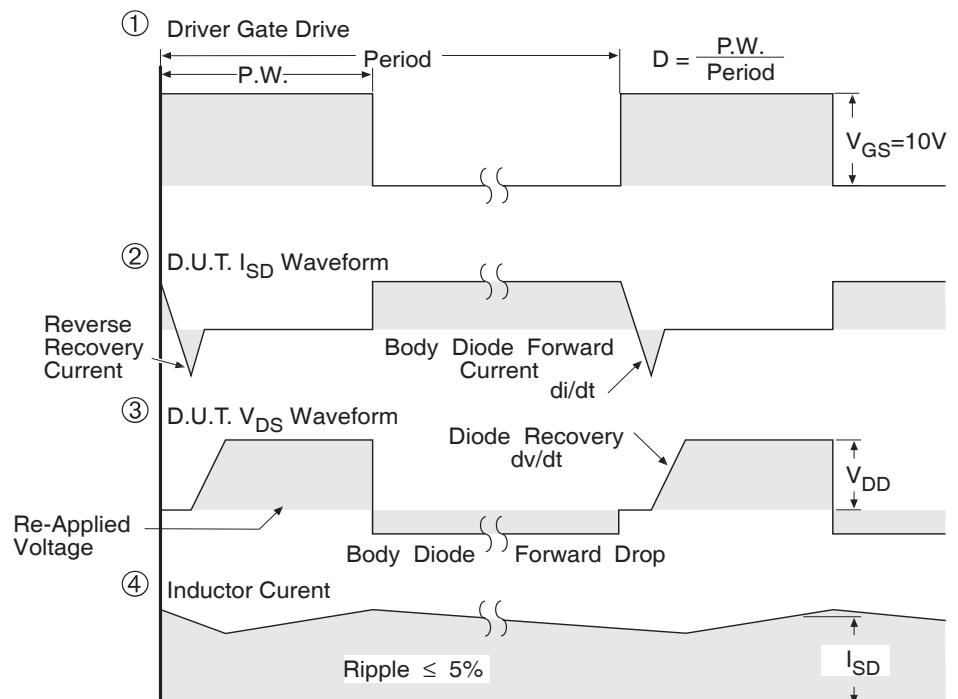
P-Channel**Fig 22b.** Gate Charge Test Circuit**Fig 22b.** Basic Gate Charge Waveform**N- and P-Channel****Fig 23.** Maximum Effective Transient Thermal Impedance, Junction-to-Ambient

Peak Diode Recovery dv/dt Test Circuit



* Reverse Polarity for P-Channel

** Use P-Channel Driver for P-Channel Measurements

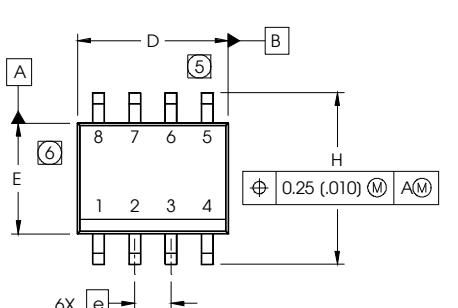


*** $V_{GS} = 5.0V$ for Logic Level and 3V Drive Devices

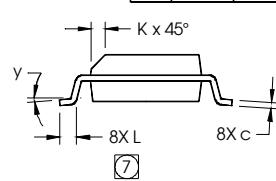
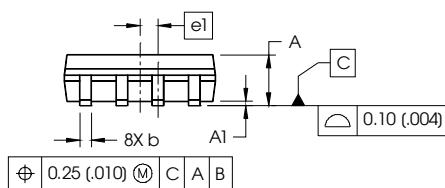
Fig 24. For N and P Channel HEXFETS

SO-8 Package Outline

Dimensions are shown in millimeters (inches)

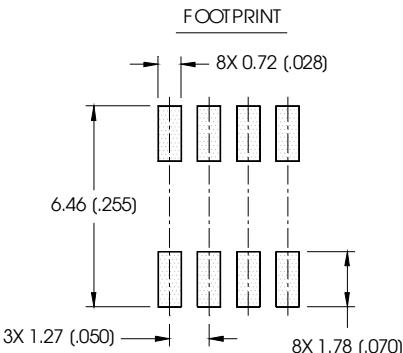


DIM	INCHES		MILLIMETERS	
	MIN	MAX	MIN	MAX
A	.0532	.0688	1.35	1.75
A1	.0040	.0098	0.10	0.25
b	.013	.020	0.33	0.51
c	.0075	.0098	0.19	0.25
D	.189	.1968	4.80	5.00
E	.1497	.1574	3.80	4.00
e	.050	BASIC	1.27	BASIC
e1	.025	BASIC	0.635	BASIC
H	.2284	.2440	5.80	6.20
K	.0099	.0196	0.25	0.50
L	.016	.050	0.40	1.27
Y	0°	8°	0°	8°

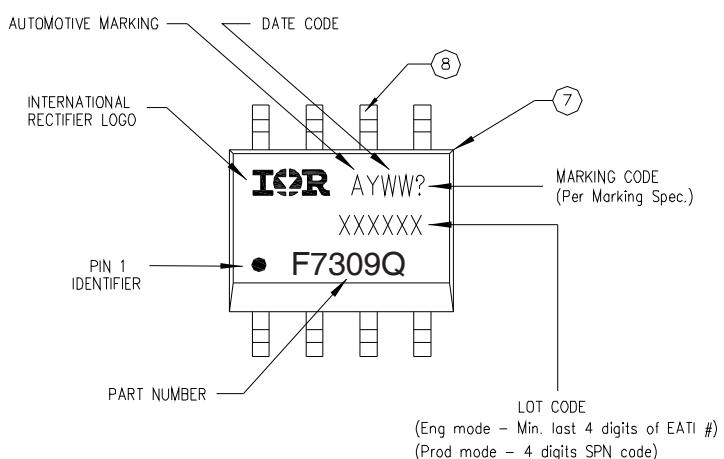


NOTES:

1. DIMENSIONING & TOLERANCING PER ASME Y14.5M-1994.
2. CONTROLLING DIMENSION: MILLIMETER
3. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
4. OUTLINE CONFORMS TO JEDEC OUTLINE MS-012AA.
5. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.15 (.006).
6. DIMENSION DOES NOT INCLUDE MOLD PROTRUSIONS. MOLD PROTRUSIONS NOT TO EXCEED 0.25 (.010).
7. DIMENSION IS THE LENGTH OF LEAD FOR SOLDERING TO A SUBSTRATE.



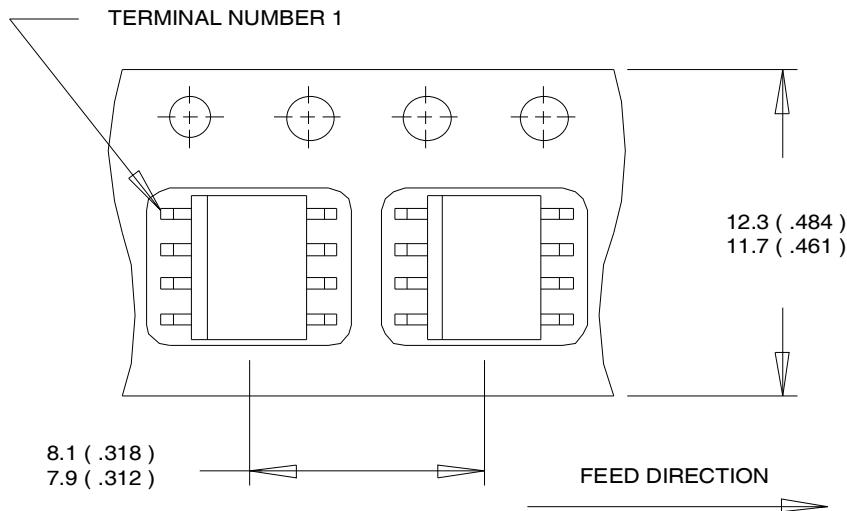
SO-8 Part Marking



Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

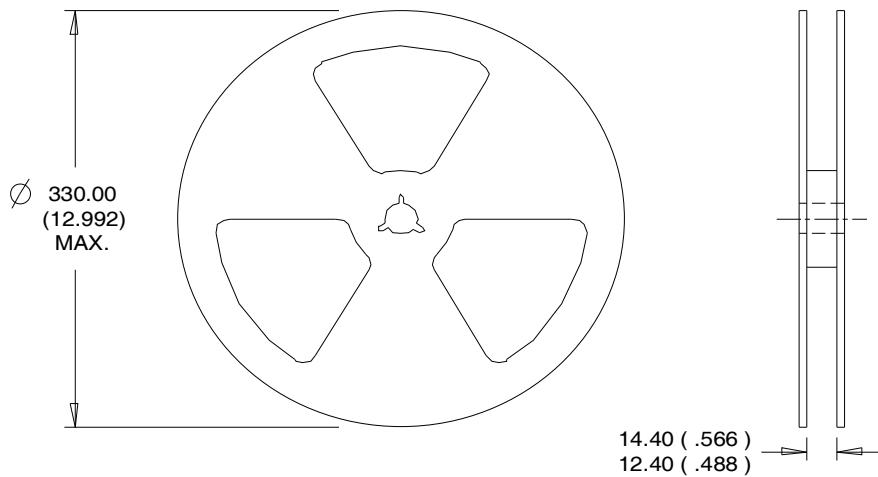
SO-8 Tape and Reel

Dimensions are shown in millimeters (inches)



NOTES:

1. CONTROLLING DIMENSION : MILLIMETER.
2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS(INCHES).
3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES :

1. CONTROLLING DIMENSION : MILLIMETER.
2. OUTLINE CONFORMS TO EIA-481 & EIA-541.

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

Qualification Information[†]

Qualification Level		Automotive (per AEC-Q101) ^{††}	
		Comments: This part number(s) passed Automotive qualification. IR's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.	
Moisture Sensitivity Level		SO-8	MSL1
ESD	Machine Model	N-CH: Class M2 (+/- 150V) ^{†††} P-CH: Class M2 (+/- 150V) ^{†††} AEC-Q101-002	
	Human Body Model	N-CH: Class H1A (+/- 500V) ^{†††} P-CH: Class H0 (+/- 250V) ^{†††} AEC-Q101-001	
	Charged Device Model	N-CH: Class C5 (+/- 2000V) ^{†††} P-CH: Class C5 (+/- 2000V) ^{†††} AEC-Q101-005	
RoHS Compliant		Yes	

† Qualification standards can be found at International Rectifier's web site: <http://www.irf.com/>

†† Exceptions to AEC-Q101 requirements are noted in the qualification report.

††† Highest passing voltage.

IMPORTANT NOTICE

Unless specifically designated for the automotive market, International Rectifier Corporation and its subsidiaries (IR) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or services without notice. Part numbers designated with the "AU" prefix follow automotive industry and / or customer specific requirements with regards to product discontinuance and process change notification. All products are sold subject to IR's terms and conditions of sale supplied at the time of order acknowledgment.

IR warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with IR's standard warranty. Testing and other quality control techniques are used to the extent IR deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

IR assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using IR components. To minimize the risks with customer products and applications, customers should provide adequate design and operating safeguards.

Reproduction of IR information in IR data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alterations is an unfair and deceptive business practice. IR is not responsible or liable for such altered documentation. Information of third parties may be subject to additional restrictions.

Resale of IR products or serviced with statements different from or beyond the parameters stated by IR for that product or service voids all express and any implied warranties for the associated IR product or service and is an unfair and deceptive business practice. IR is not responsible or liable for any such statements.

IR products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or in other applications intended to support or sustain life, or in any other application in which the failure of the IR product could create a situation where personal injury or death may occur. Should Buyer purchase or use IR products for any such unintended or unauthorized application, Buyer shall indemnify and hold International Rectifier and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that IR was negligent regarding the design or manufacture of the product.

IR products are neither designed nor intended for use in military/aerospace applications or environments unless the IR products are specifically designated by IR as military-grade or "enhanced plastic." Only products designated by IR as military-grade meet military specifications. Buyers acknowledge and agree that any such use of IR products which IR has not designated as military-grade is solely at the Buyer's risk, and that they are solely responsible for compliance with all legal and regulatory requirements in connection with such use.

IR products are neither designed nor intended for use in automotive applications or environments unless the specific IR products are designated by IR as compliant with ISO/TS 16949 requirements and bear a part number including the designation "AU". Buyers acknowledge and agree that, if they use any non-designated products in automotive applications, IR will not be responsible for any failure to meet such requirements.

For technical support, please contact IR's Technical Assistance Center
<http://www.irf.com/technical-info/>

WORLD HEADQUARTERS:
101 N. Sepulveda Blvd., El Segundo, California 90245
Tel: (310) 252-7105

Revision History

Date	Comments
3/28/2014	<ul style="list-style-type: none">• Added "Logic Level Gate Drive" bullet in the features section on page 1• Updated data sheet with new IR corporate template